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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/750,389	12/31/2003	Tony Albrecht	5367-65	8976
7590 06/15/2005			EXAMINER	
COHEN, PONTANI LIBERMAN & PAVANE			LE, THAO X	
Suite 1210 551 Fifth Avenue New York, NY 10176			ART UNIT	PAPER NUMBER
			2814	
			DATE MAILED: 06/15/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/750,389	ALBRECHT ET AL.			
Office Action Summary	Examiner	Art Unit			
	Thao X. Le	2814			
The MAILING DATE of this communication app					
Period for Reply					
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply If NO period for reply is specified above, the maximum statutory period we Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	16(a). In no event, however, may a reply be time within the statutory minimum of thirty (30) days ill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONET	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
1) Responsive to communication(s) filed on <u>30 August 2004</u> .					
2a)⊠ This action is FINAL . 2b)☐ This	This action is FINAL. 2b) This action is non-final.				
,	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.				
Disposition of Claims					
4) Claim(s) 1-26 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) Claim(s) is/are allowed. 6) Claim(s) 1-26 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or election requirement.					
Application Papers					
9) ☐ The specification is objected to by the Examiner.					
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.					
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).					
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority document: 2. Certified copies of the priority document: 3. Copies of the certified copies of the priority application from the International Bureau * See the attached detailed Office action for a list	s have been received. s have been received in Applicati rity documents have been receive u (PCT Rule 17.2(a)).	ion No ed in this National Stage			
Attachment(s)					
1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413) Notice of Draffsperson's Patent Drawing Review (PTO-948) Paper No(s)/Mail Date					
 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 		ate Patent Application (PTO-152)			

Application/Control Number: 10/750,389

Art Unit: 2814

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1-5, 9, 22, 24 are rejected under 35 U.S.C. 102(b) as being anticipated by US 5717226 to Lee et al.

Regarding claim 1, Lee discloses a light-emitting diode chip in fig. 3C having an epitaxial semiconductor layer sequence (31/32/33) with an active zone 32, column 3 line 27, that emits electromagnetic radiation and an electrical contact structure (34/35/36) comprising a radiation-transmissive electrical current expansion layer 35 which contains ZnO, column 3 line 31, and an electrical connection layer 36, column 4 line 5, wherein the current expansion layer 35 is applied on a cladding layer of the semiconductor layer and comprises a window, in which the connection layer 36 is applied on said cladding layer 33, column 3 line 27, of the semiconductor layer sequence, the connection layer 36 is electrically conductively connected to the current expansion layer 35, and wherein junction between the connection layer 36 and the cladding layer 33, during the operation of the light-emitting diode chip, is not electrically conductive, column 3 line 3 line 60-65, or is only poorly electrically conductive such that an entire, or virtually the

entire, current from the connection layer 36 flows via the current expansion layer 35 into the semiconductor layer sequence.

Although the prior art does not specially disclose the during the operation of the light-emitting diode chip, is not electrically conductive or is only poorly electrically conductive such that an entire, or virtually the entire, current from the connection layer flows via the current expansion layer into the semiconductor layer sequence limitation, this feature is seen to be inherently teaching of that limitation because Lee discloses the material and structure substantially identical to claimed invention, claimed properties or functions are presumed to be inherent. *In re Best*, 195 USPQ 430, 433 (CCPA 1977).

Regarding claim 2, Lee discloses the light-emitting diode chip according to claim 1, wherein the connection layer 36 comprises a metal, column 4 line 5, and the junction between the connection layer 36 and the cladding layer 33 comprises an electrical potential barrier, column 3 line 60-65.

Regarding claims 3-4, 22 Lee discloses the light-emitting diode chip according to claim 1, the sheet resistance of intermediate layers of the semiconductor layer sequence between the active zone and the electrical contact structure is greater than or equal to 200 Ω /sq, wherein the current expansion layer 35 comprises a sheet resistance of less than or equal to 190 Ω /sq or 30 Ω /sp.

Although the prior art does not specially disclose the sheet resistance limitation, this feature is seen to be inherently teaching of that limitation because Lee discloses the material and structure substantially identical to claimed

invention, claimed properties or functions are presumed to be inherent. *In re Best*, 195 USPQ 430, 433 (CCPA 1977).

Regarding claim 5, Lee discloses the light-emitting diode chip according to claim 1, wherein the connection layer 36 extends beyond the window on a side of the current expansion layer 35 which is remote from the semiconductor layer sequence (31/32/33) and is applied to a front-side surface of the current expansion layer 35 so as to partly cover the current expansion layer 35 and so that the junction between the connection layer 36 and the current expansion layer 35 is electrically conductive in this region, fig. 3C.

Regarding claims 9, 24 Lee discloses the light-emitting diode chip according to claim 1, wherein the layer p-type AlGaInP is doped with a dopant concentration of between about 1x10¹⁸, column 1 line 46.

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation

under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

5. Claim 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 5717226 to Lee et al. to US 6693352 to Huang et al.

Regarding claims 6, Lee discloses the light-emitting diode chip according to claim

Wherein the semiconductor layer sequence is based on AlGalnP, column 25-28.

But Lee does not discloses the semiconductor layer $In_xGa_yAI_{1-x-y}P$ where $0 \le x \le 1, 0 \le y \le 1$ and $x + y \le 1$

However, Huang discloses the semiconductor layer $Al_xGa_yIn_{1-x-y}P_{1-z}$ where $0 \le x \le 1$, $0 \le y \le 1$, $0 \le x + y \le 1$, and $0 \le z \le 1$. Accordingly, it would have been obvious to one of ordinary skill in art to use the semiconductor layer teaching of Huang in Lee's device in the range as claimed, because it has been held that where the general conditions of the claims are discloses in the prior art, it is not inventive to discover the optimum or workable range by routine experimentation. See In re Aller, 220 F.2d 454, 105 USPQ 233, 235 (CCPA 1955).

6. Claims 7-8, 23 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 5717226 to Lee et al. to US Pub 2003/0059972 to Ikeda et al.

Regarding claims 7, 23, Lee discloses the light-emitting diode chip according to claim 1, wherein the cladding layer 33 comprises AlGaInP, column 4 line 17.

But Lee does not disclose the cladding layer comprises $Al_xGa_{1-x}As_yP_{1-y}$ where $0 \le x \le 1$ and $0 \le y \le 1$ and where $0.1 \le x \le 0.5$ and y = 1 or where x = 0 and y = 0.

However, Ikeda discloses the cladding layer can comprise AlGaAs, GalnP, and AlGalnP [0033]. At the time of the invention was made; it would have been obvious to one of ordinary skill in the art to combine the cladding layer teaching of Ikeda to replace the cladding layer of Lee, because such material substitution would have been considered a mere substitution of art-recognized equivalent values, MPEP 2144.06. With respect to the x any y concentration, it would have been obvious to one of ordinary skill in art to combine the teaching of Lee and Ikeda in the range as claimed, because it has been held that where the general conditions of the claims are discloses in the prior art, it is not inventive to discover the optimum or workable range by routine experimentation. See In re Aller, 220 F.2d 454, 105 USPQ 233, 235 (CCPA 1955).

Regarding claim 8, Lee does not discloses the light-emitting diode chip according to claim 7 wherein the cladding layer is p-doped with at least one of a the dopant Zn and C.

However, Lee discloses layer 33 is P-type cladding layer. At the time the invention was made; it would have been obvious to one of ordinary skill in the art to understand that Zn would be a typical material used in the art as a dopant of p-type for cladding layer, see Wang (6469324) column 2 lines 26, Sasaki (6074889) column 1 lines 48-51, or Takeoka (5789773) column 1 line 61.

7. Claims 10-13, 25-26 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 5717226 to Lee et al. to US 6346719 to Udagawa et al.

Regarding to claims 10-13, 25-26 Lee discloses the current expansion layer 35 has general thickness.

But Lee does not discloses the current expansion layer comprises Al, wherein the proportion of Al between 0% and 10%, wherein the thickness between 100-600 nm or the thickness corresponding about a quarter of the wavelength of a radiation emitted by the light-emitting diode chip.

However, Udagawa discloses the light-emitting diode in fig. 6 wherein the expansion layer 406 comprises AI, column 8 line 56, wherein the proportion of AI between 0% and 10%, column 8 line 57, wherein the thickness between 100-600 nm, column 8 line 64. At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the ZnO:AI layer 406 teaching of Udagawa with Lee's device, because AI doped ZnO would have created a specific resistance level for layer ZnO as taught by Udagawa, column 8 line 59.

8. Claims 14-21 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 5717226 to Lee et al. to JP 2001036131 to Udagawa.

Regarding claims 14-21, Lee does not discloses the light emitting diode wherein the current expansion layer is provided with watertight material such that the current expansion layer is adequately protected against moisture, wherein watertight material is applied to free areas of the contact layer, wherein watertight material is applied to all the free areas of the contact layer, wherein the watertight material is a dielectric that is

transparent to an electromagnetic radiation emitted by the light-emitting diode chip, wherein the dielectric comprises one or more of the substances Si_xN_y, SiO₁, SiO₂, Al₂O₃ and SiO_xN_y, 19, wherein a refractive index of the watertight material is less than the refractive index of the current expansion layer and is adapted so as to significantly minimized reflections of the radiation emitted by the light-emitting diode chip at interfaces with respect to the watertight material, wherein the current expansion layer has a thickness corresponding to about an integer multiple of half the wavelength of a radiation emitted by the light-emitting diode chip, and the watertight material has a thickness corresponding to about a quarter of said wavelength, wherein the thickness of the watertight material is in a range of between 50 and 200 nm inclusive.

However, Udagawa discloses the light emitting diode in fig. 1 wherein the current expansion layer 107 is provided with watertight material 108 in such a way that it is adequately protected against moisture, wherein watertight material is applied to free areas of the contact layer, wherein watertight material 108 is applied to all the free areas of the contact layer, wherein the watertight material 108 is a dielectric that is transparent to an electromagnetic radiation emitted by the light-emitting diode chip, wherein the dielectric comprises one or more of the substances Si_xN_y, SiO₁, SiO₂, Al₂O₃ and SiO_xN_y, see abstract, wherein the refractive index of the watertight material is less than the refractive index of the current expansion layer and is adapted to the greatest possible extent in particular for a minimization of reflections of the radiation emitted by the light-emitting diode chip at interfaces with respect to the watertight material, see

abstract, wherein the current expansion layer 107 has a general thickness, wherein the thickness of the watertight material 108 has a general thickness. At the time the invention was made; it would have been obvious to one of ordinary skill in the art to use the watertight layer teaching of Udagawa with Lee's device, because it would have provided the protection and improved light emitting efficiency as taught by Udagawa, see abstract.

With respect to the thickness, it would have been obvious to one of ordinary skill in art to use the general thickness teaching of Udagawa with Lee's device in the range as claimed, because it has been held that where the general conditions of the claims are discloses in the prior art, it is not inventive to discover the optimum or workable range by routine experimentation. See In re Aller, 220 F.2d 454, 105 USPQ 233, 235 (CCPA 1955).

Response to Arguments

9. Applicant's arguments filed 09 Mar 2005 have been fully considered but they are not persuasive. The Applicant argues that Lee does not disclose the current expansion layer is applied on a cladding layer of the semiconductor layer. It is apparent that the Applicant interpretation of the word 'ON' is 'in direct contact with'. However, the Examiner submits that the word 'ON' also means 'in close proximity with'. For this reason, Lee expansion layer 35 would read on the claimed limitation. It is noted that the feature upon which the Applicant relies on is not recited in the rejected claim. Although the claim are interpreted in light of the specification, limitation from the specification are

not read into the claim, see In re Van Geuns, 988 F.22d 1181, 26 USPQ2d 1057 (Fed. Cir. 1993). Furthermore, it is proper to use the specification to interpret what the applicant meant by a word or phase recited in the claim. However, it is not proper to read the limitations appearing in the specification into the claim when these limitations are not recited in the claim; *Intervet America Inc. v. Kee-Vet Lab. Inc*, 887 F.2d 1050, 1053, 12 USPQ2d 1474, 1476 (Fed. Cir. 1989).

Conclusion

10. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

11. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thao X. Le whose telephone number is (571) 272-1708. The examiner can normally be reached on M-F from 8:00 AM - 4:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael M. Fahmy can be reached on (571) 272 -1705. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Thao X. Le 10 June 2005

> LONG PHAM PRIMARY EXAMINER